

Single N-channel MOSFET

ELM13424CA-S

■General description

ELM13424CA-S uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and operation with gate voltages as low as 2.5V.

■Features

- $V_{ds}=30V$
- $I_d=3.8A$ ($V_{gs}=10V$)
- $R_{ds(on)} < 55m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} < 65m\Omega$ ($V_{gs}=4.5V$)
- $R_{ds(on)} < 85m\Omega$ ($V_{gs}=2.5V$)

■Maximum absolute ratings

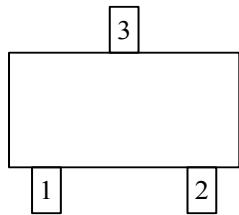
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	30	V	
Gate-source voltage	V_{gs}	± 12	V	
Continuous drain current	I_d	3.8	A	
		3.1		
Pulsed drain current	I_{dm}	15	A	3
Power dissipation	P_d	1.4	W	2
		0.9		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■Thermal characteristics

Parameter	Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$R_{\theta ja}$	70	90	°C/W	1
Maximum junction-to-ambient		100	125	°C/W	
Maximum junction-to-lead	$R_{\theta jl}$	63	80	°C/W	

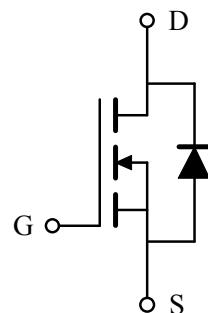
■Pin configuration

SOT-23(TOP VIEW)



Pin No.	Pin name
1	GATE
2	SOURCE
3	DRAIN

■Circuit



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■Electrical characteristics

T_a=25°C

Parameter	Symbol	Condition		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BV _{dss}	Id=250μA, V _{gs} =0V		30			V	
Zero gate voltage drain current	Id _{ss}	V _{ds} =30V, V _{gs} =0V	T _j =55°C			1	μA	
						5		
Gate-body leakage current	I _{gss}	V _{ds} =0V, V _{gs} =±12V				±100	nA	
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , Id=250μA		0.5	1.0	1.5	V	
On state drain current	Id(on)	V _{gs} =10V, V _{ds} =5V		15			A	
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =10V, Id=3.8A			43	55	mΩ	
		T _j =125°C			70	84		
		V _{gs} =4.5V, Id=3.5A			47	65		
		V _{gs} =2.5V, Id=1A			59	85		
Forward transconductance	G _{fs}	V _{ds} =5V, Id=3.8A			14		S	
Diode forward voltage	V _{sd}	Is=1A, V _{gs} =0V			0.75	1.00	V	
Max. body-diode continuous current	Is					1.5	A	
DYNAMIC PARAMETERS								
Input capacitance	C _{iss}	V _{gs} =0V, V _{ds} =15V, f=1MHz		185	235	285	pF	
Output capacitance	C _{oss}			25	35	45	pF	
Reverse transfer capacitance	C _{rss}			10	18	25	pF	
Gate resistance	R _g	V _{gs} =0V, V _{ds} =0V, f=1MHz		2.1	4.3	6.5	Ω	
SWITCHING PARAMETERS								
Total gate charge (V _{gs} =10V)	Q _g	V _{gs} =10V, V _{ds} =15V, Id=3.8A			10.00	12.00	nC	
Total gate charge (V _{gs} =4.5V)					4.70			
Gate-source charge	Q _{gs}				0.95		nC	
Gate-drain charge	Q _{gd}				1.60		nC	
Turn-on delay time	t _{d(on)}	V _{gs} =10V, V _{ds} =15V RL=3.95Ω, R _{gen} =3Ω			3.5		ns	
Turn-on rise time	t _r				1.5		ns	
Turn-off delay time	t _{d(off)}				17.5		ns	
Turn-off fall time	t _f				2.5		ns	
Body diode reverse recovery time	t _{rr}	If=3.8A, dl/dt=100A/μs			8.5	11.0	ns	
Body diode reverse recovery charge	Q _{rr}	If=3.8A, dl/dt=100A/μs			2.6	3.5	nC	

NOTE :

- The value of R_{θja} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25°C. The value in any given application depends on the user's specific board design.
- The power dissipation P_d is based on T_{j(max)}=150°C, using ≤10s junction-to-ambient thermal resistance.
- Repetitive rating, pulse width limited by junction temperature T_{j(max)}=150°C. Ratings are based on low frequency and duty cycles to keep initialT_J=25°C.
- The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjl} and lead to ambient.
- The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{j(max)}=150°C. The SOA curve provides a single pulse rating.



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■ Typical electrical and thermal characteristics

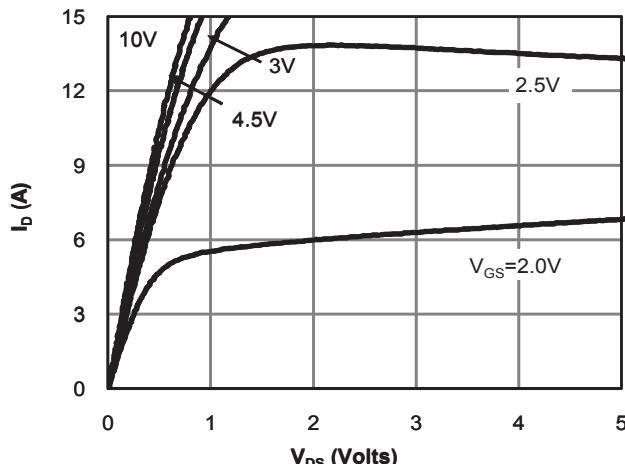


Fig 1: On-Region Characteristics (Note E)

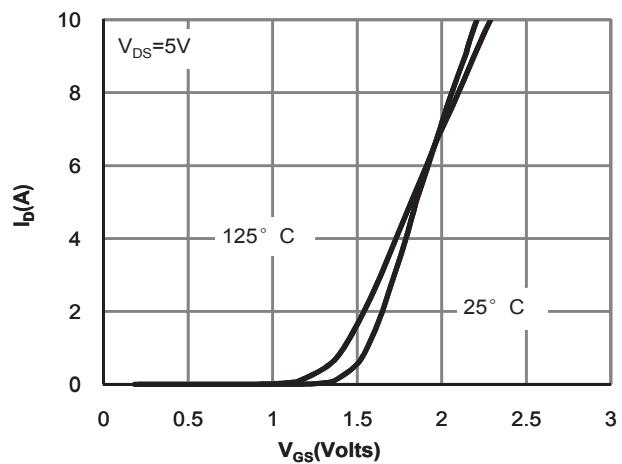


Figure 2: Transfer Characteristics (Note E)

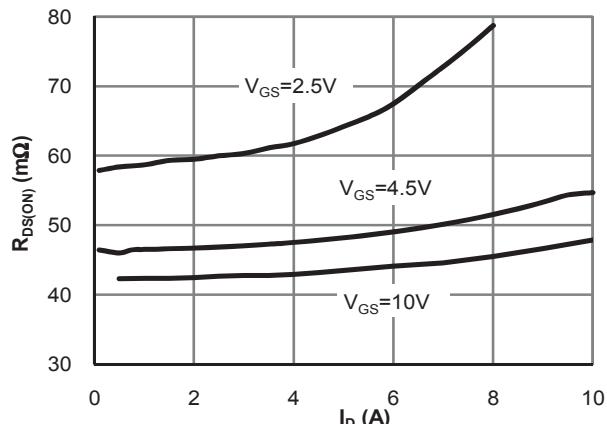


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

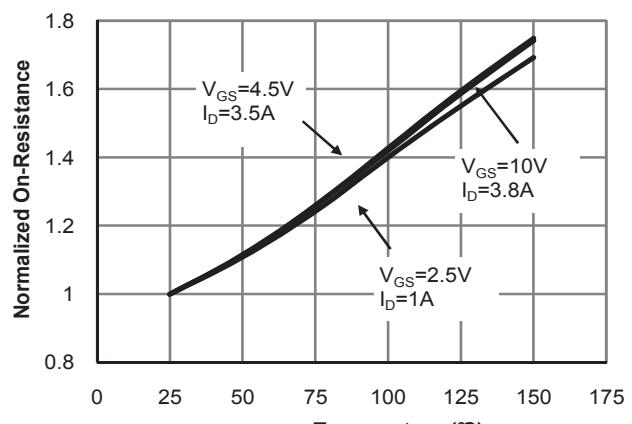


Figure 4: On-Resistance vs. Junction Temperature (Note E)

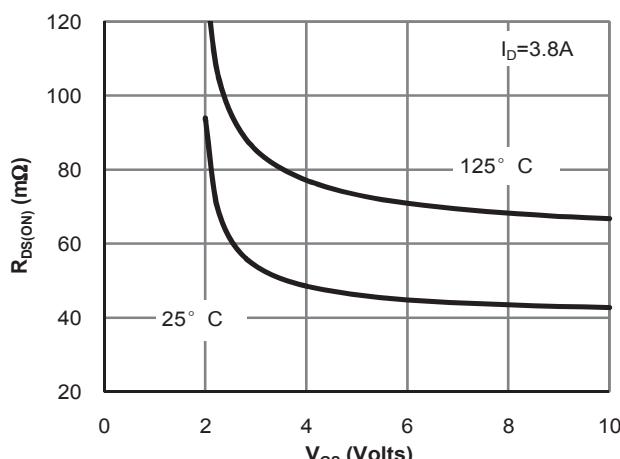


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

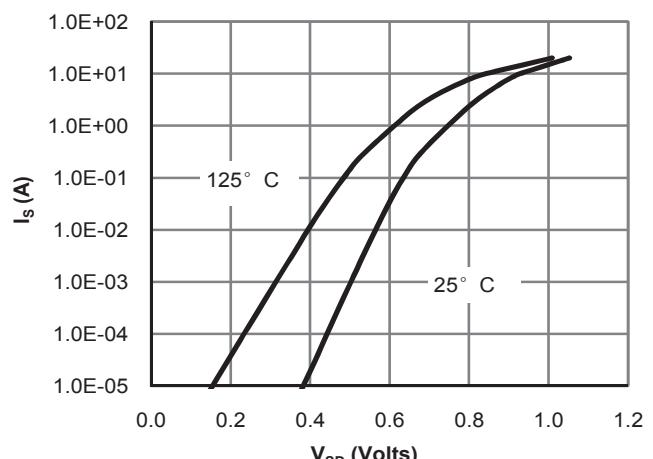


Figure 6: Body-Diode Characteristics (Note E)

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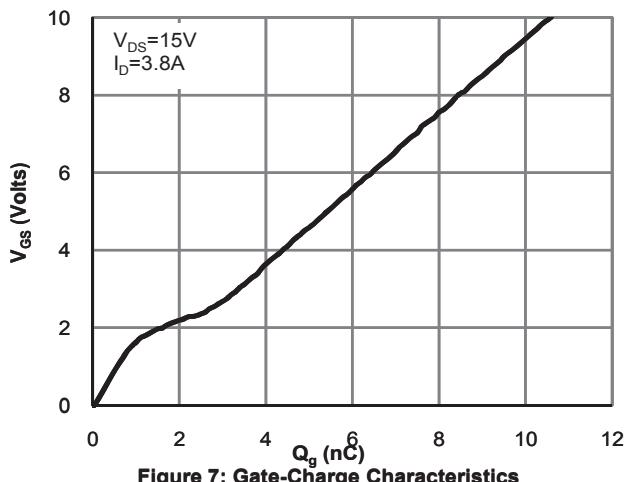


Figure 7: Gate-Charge Characteristics

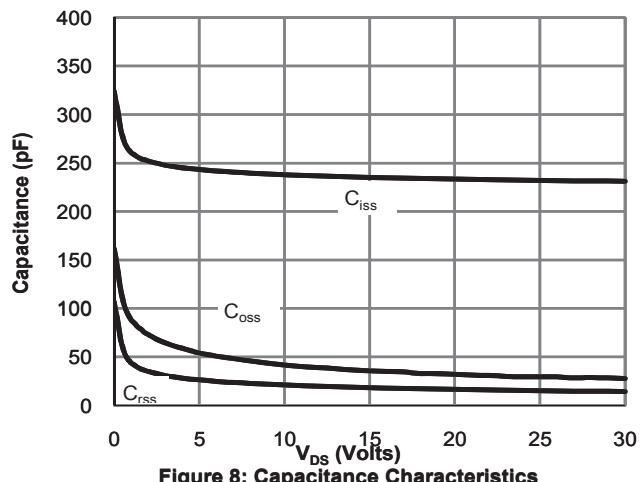


Figure 8: Capacitance Characteristics

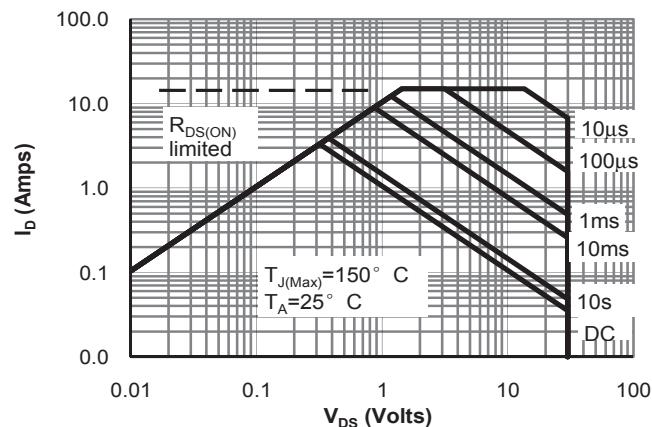


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

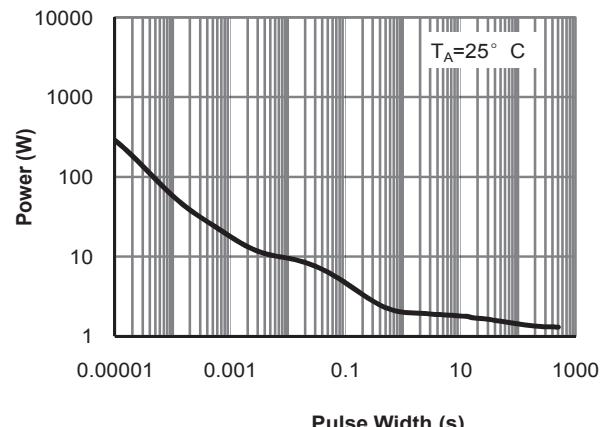


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

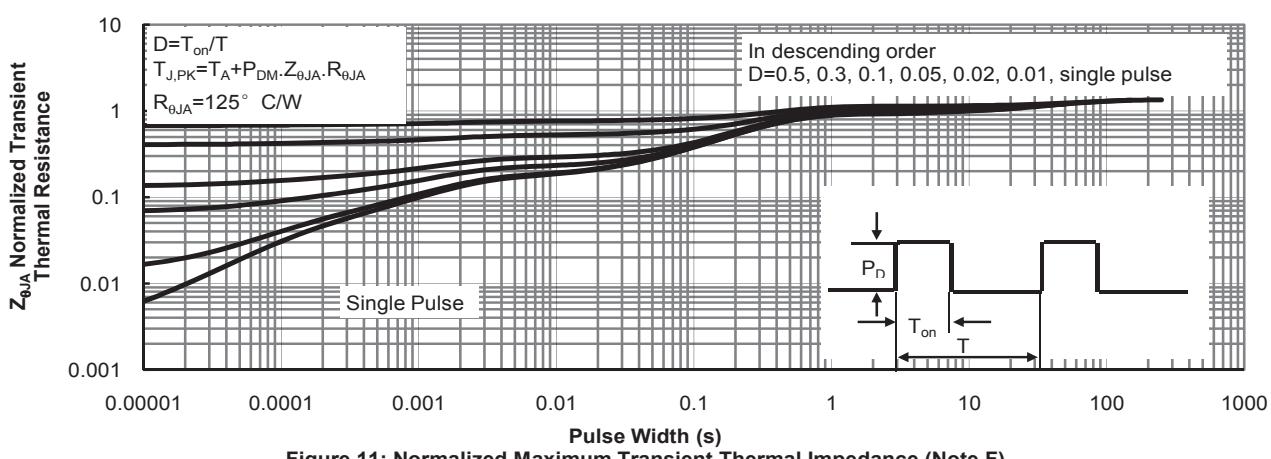
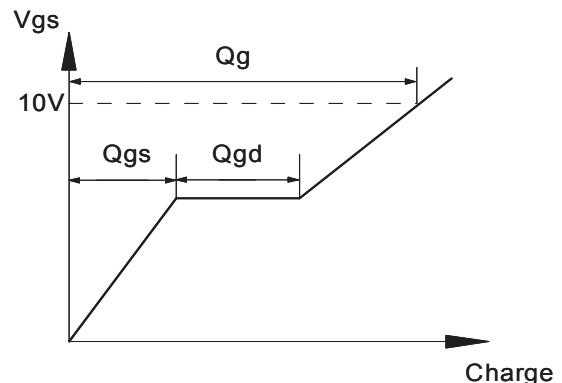
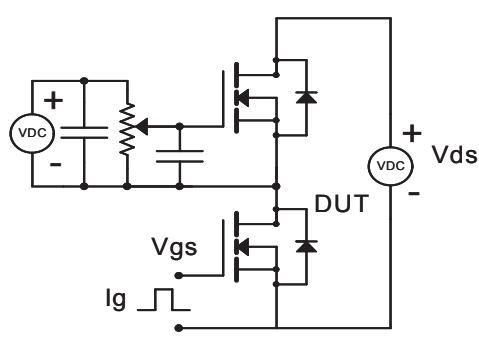


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

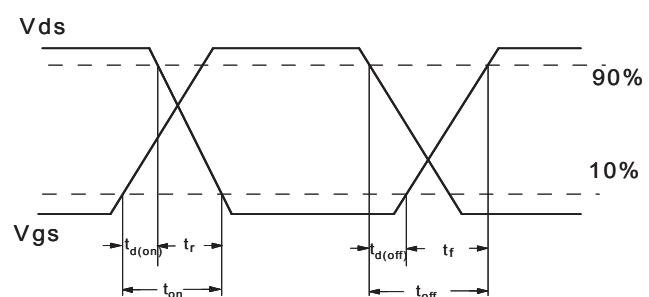
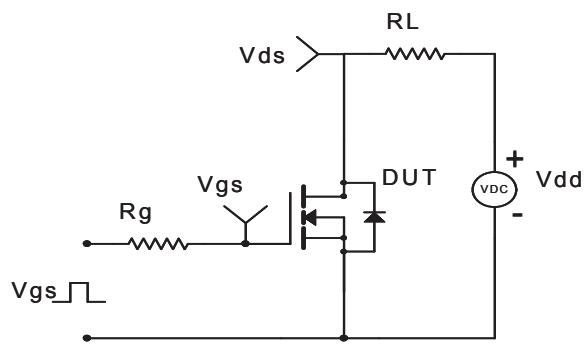
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Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

